

STL50NH3LL

N-channel 30V - 0.011Ω - 13A - PowerFLATTM (6x5) Ultra low gate charge STripFETTM Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STL50NH3LL	30V	<0.013Ω	13A ⁽⁴⁾

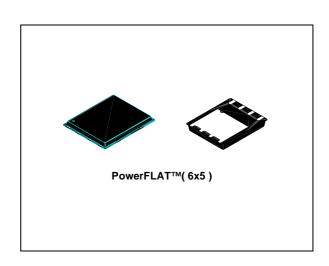
- Improved die-to-footprint ratio
- Very low profile package (1mm max)
- Very low thermal resistance
- Very low gate charge
- Low threshold device

Description

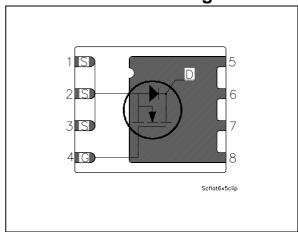
This application specific Power MOSFET is the latest generation of STMicroelectronics unique "STripFETTM" technology. The resulting transistor is optimized for low on-resistance and minimal gate charge. The Chip-scaled PowerFLATTM package allows a significant board space saving, still boosting the performance.

Applications

Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STL50NH3LL	L50NH3LL	PowerFLAT™ (6x5)	Tape & reel

Contents: STL50NH3LL

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STL50NH3LL Electrical ratings

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{GS} ⁽¹⁾	Gate-source voltage	± 16	V
V _{GS} ⁽²⁾	Gate-source voltage	± 18	V
I _D (3)	Drain current (continuous) at T _C = 25°C	27	Α
I _D ⁽⁴⁾	Drain current (continuous) at T _C =100°C	8.1	Α
I _{DM} ⁽⁵⁾	Drain current (pulsed)	108	Α
I _D ⁽⁴⁾	Drain current (continuous) at T _C = 25°C	13	Α
P _{TOT} (4)	Total dissipation at T _C = 25°C	4	W
P _{TOT} (3)	Total dissipation at T _C = 25°C	60	W
	Derating factor	0.03	W/°C
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

- 1. Continuous mode
- 2. Guaranteed for test time \leq 15ms
- 3. The value is rated according $R_{\mbox{\scriptsize thj-c}}$ and is limited by wire bonding
- 4. The value is rated according $R_{thj\text{-pcb}}$
- 5. Pulse width limited by safe operating area

Table 2. Thermal resistance

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case (Drain)	2.08	°C/W
R _{thj-pcb} (1)	Thermal resistance junction-ambient	31.3	°C/W

^{1.} When mounted on FR-4 board of 1inch 2 , 2oz Cu, t < 10sec

Table 3. Avalanche data

Symbol	Parameter	Value	Unit
I _{AR}	Not-repetitive avalanche current (pulse width limited by Tj Max)	6	Α
E _{AS}	Single pulse avalanche energy (starting Tj=25°C, Id=Iav, Vdd=24V)	800	mJ

Electrical characteristics STL50NH3LL

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250\mu A, V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating, V _{DS} = Max rating @125°C			1 10	μA μA
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±16V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	1			V
R _{DS(on)}	Static drain-source on resistance	V_{GS} = 10V, I_{D} = 6.5A V_{GS} = 4.5V, I_{D} = 6.5A		0.011 0.012	0.013 0.015	Ω Ω

Table 5. Dynamic

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 10V, I_D = 6.5A$		32		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V_{DS} =25V, f=1 MHz, V_{GS} =0		965 285 38		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} =15V, I_{D} = 13A V_{GS} =4.5V (see Figure 7)		9 3.7 3	12	nC nC nC
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20mV open drain	0.5	1.5	2.5	Ω

^{1.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 6. Switching times

Symbol	Parameter	Test condictions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} =15V, I_{D} = 6.5A, R_{G} =4.7 Ω , V_{GS} =4.5V (see Figure 13)		15 32 18 8.5		ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test condictions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				13	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				52	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =13A, V _{GS} =0			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} =13A, di/dt = 100A/ μ s, V_{DD} =20V, Tj=150°C (see Figure 15)		24 17.4 1.45		ns nC A

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Electrical characteristics STL50NH3LL

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

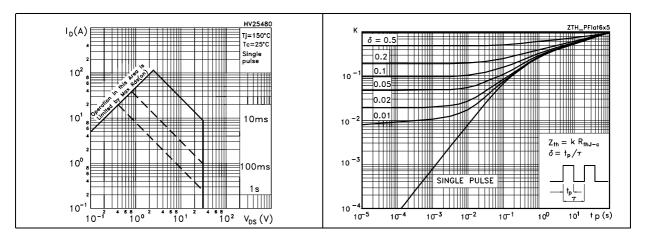


Figure 3. Output characterisics

Figure 4. Transfer characteristics

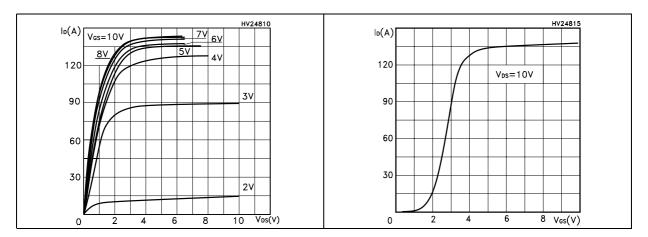
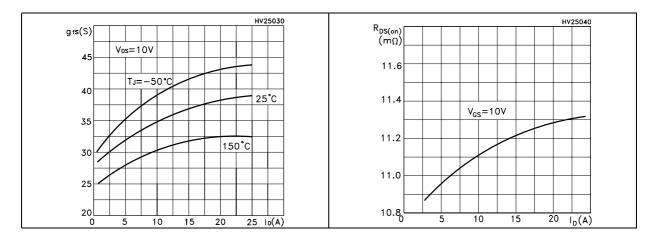


Figure 5. Transconductance

Figure 6. Static drain-source on resistance



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Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

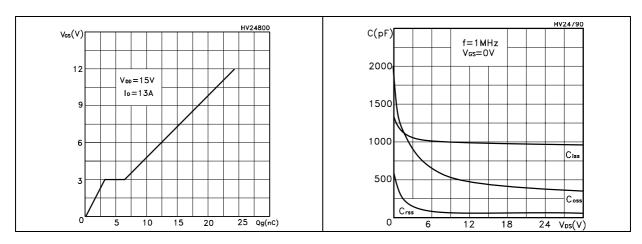


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

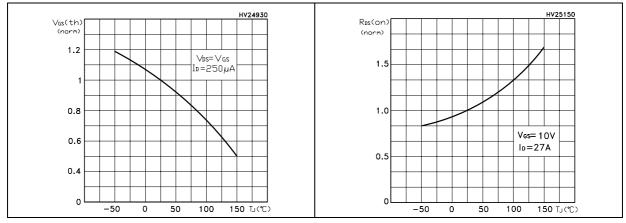
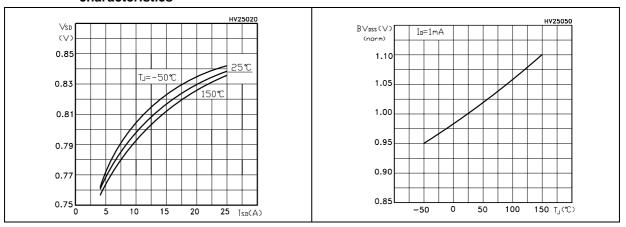


Figure 11. Source-drain diode forward characteristics

Figure 12. Normalized B_{VDSS} vs temperature



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Test circuit STL50NH3LL

3 Test circuit

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

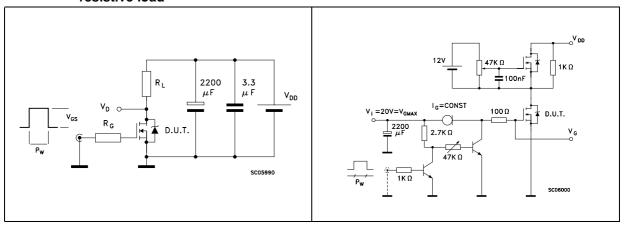


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

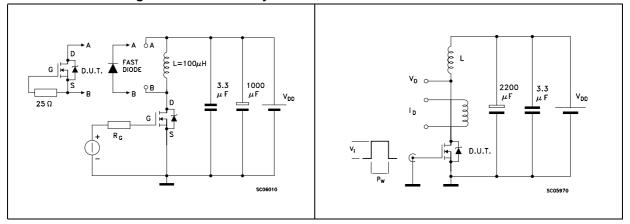
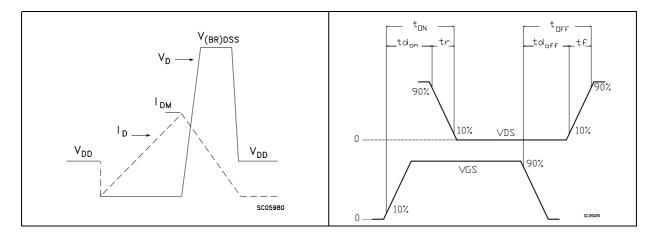


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



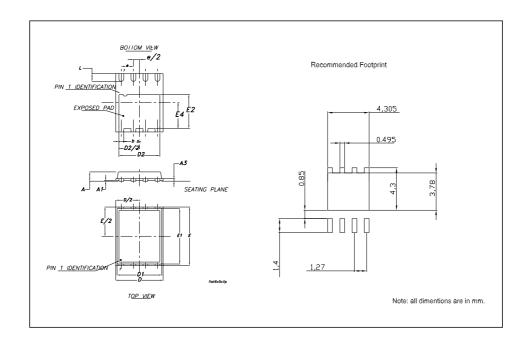
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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

PowerFLAT™ (6x5) MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	0.80	0.83	0.93	0.031	0.032	0.036
A1		0.02	0.05		0.0007	0.0019
А3		0.20			0.007	
b	0.35	0.40	0.47	0.013	0.015	0.018
D		5.00			0.196	
D1		4.75			0.187	
D2	4.15	4.20	4.25	0.163	0.165	0.167
E		6.00			0.236	
E1		5.75			0.226	
E2	3.43	3.48	3.53	0.135	0.137	0.139
E4	2.58	2.63	2.68		0.103	0.105
е		1.27			0.050	
L	0.70	0.80	0.90	0.027	0.031	0.035



STL50NH3LL Revision history

5 Revision history

Table 8. Revision history

Date	Revision	Changes		
21-Jul-2005	1	First Release		
14-Apr-2005	2	Final version		
20-Jun-2005	3	Updated mechanical data		
22-Jun-2005	4	New Rg value on <i>Table 6</i>		
30-Sep-2005	5	Inserted ecopack indication		
04-Jan-2006	6	New footprint		
30-Mar-2006	7	New template		

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